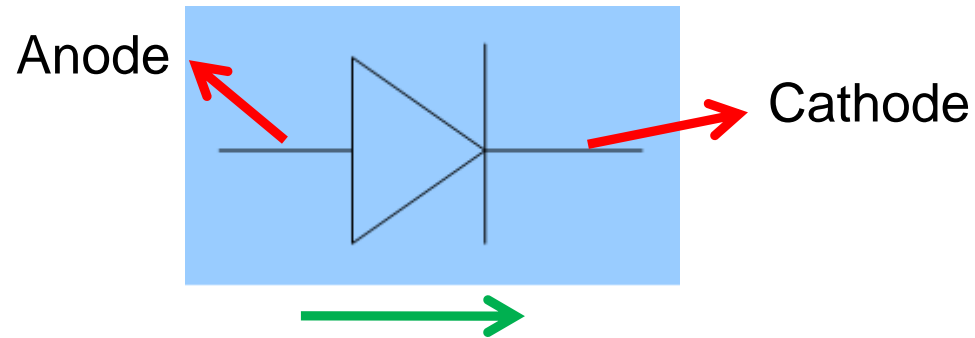


ESc201 : Introduction to Electronics

Diodes

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Dept. of Electrical Engineering
IIT Kanpur

Diode

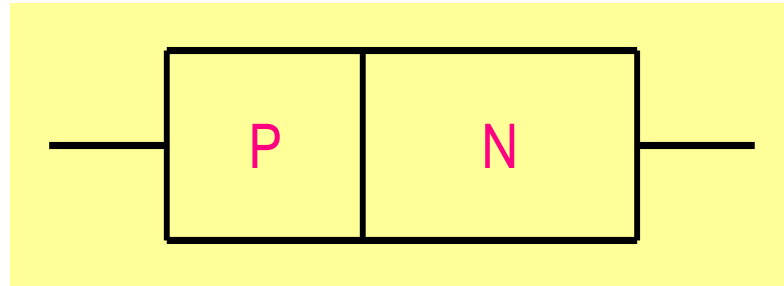
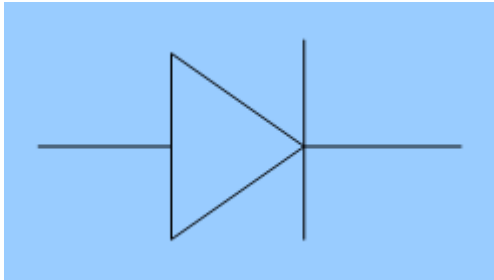


- Like resistors and capacitors, diodes are two terminal devices
 - The 2 terminals are called **Anode** and **Cathode**
- It conducts current in one direction only (from anode to cathode)

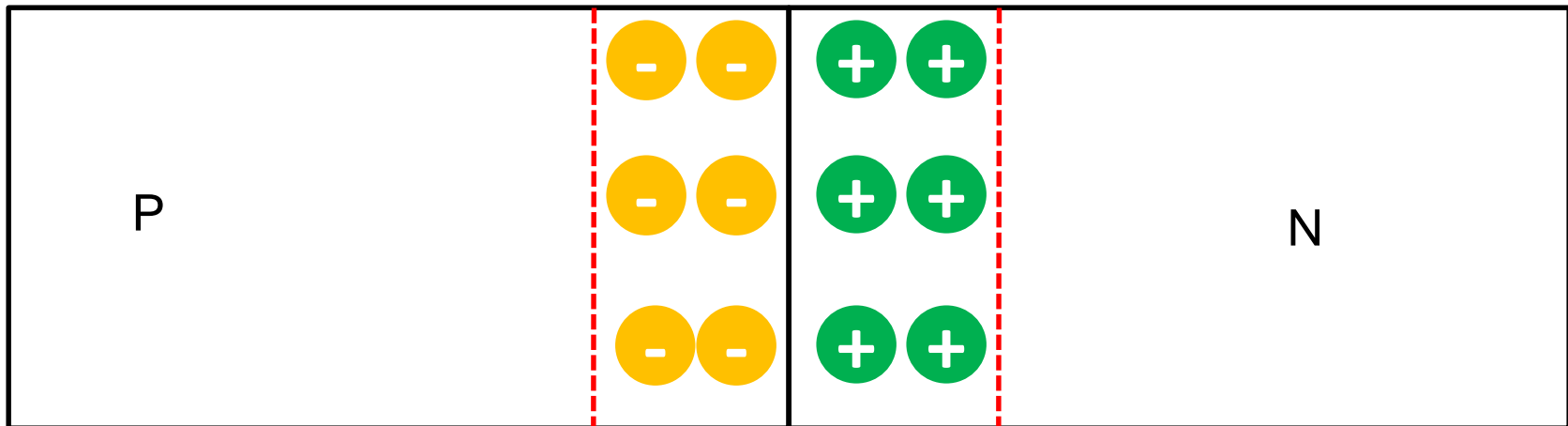
Diodes are nonlinear, two terminal, passive electrical devices

Diodes only consume power

PN Junction Diode

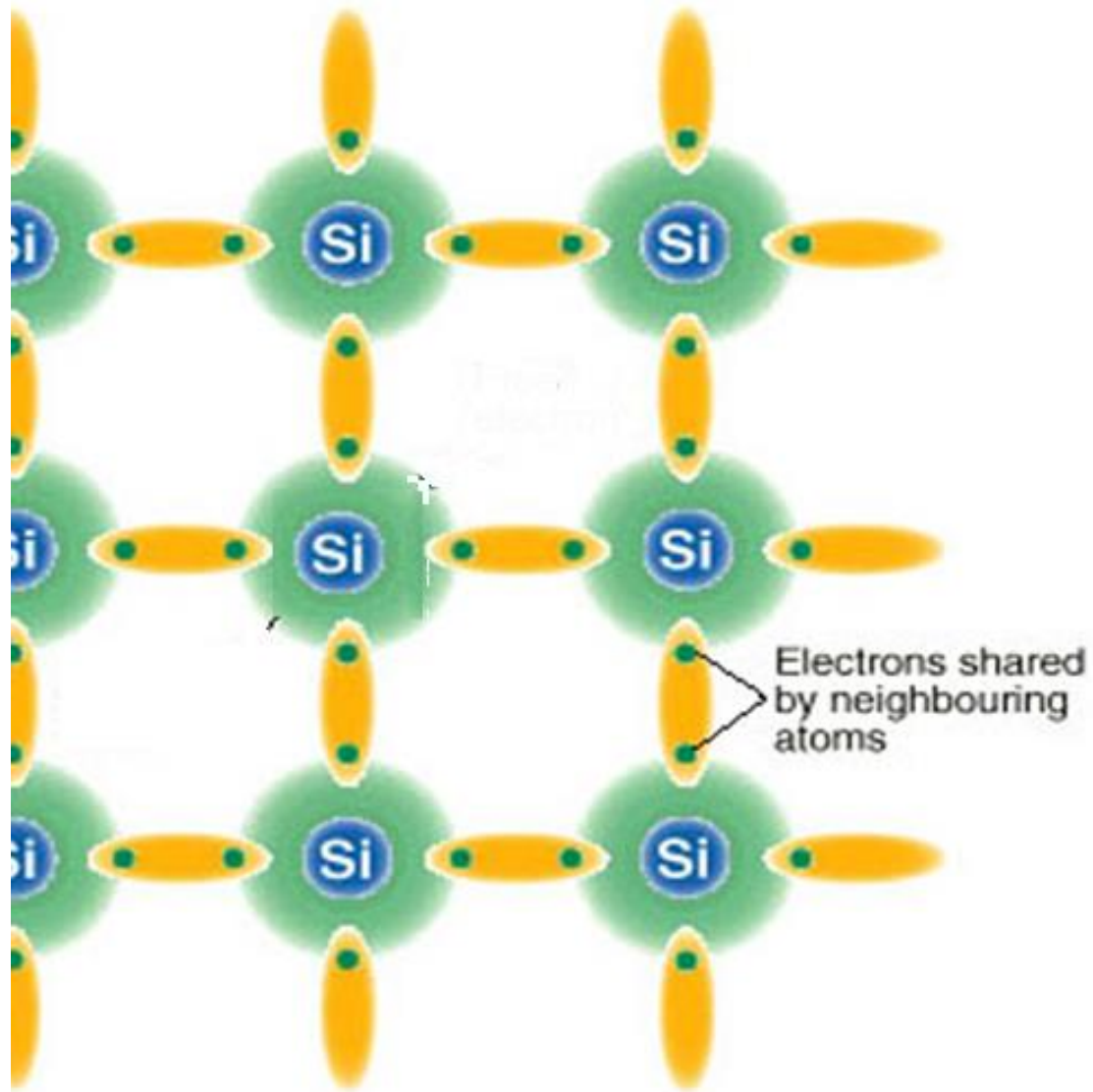


Inside a PN junction at equilibrium (zero applied voltage), there is built-in voltage with N region being positive and P-region negative.



The built-in voltage (also called potential barrier) prevents electrons and holes to give rise to current.

Simplified Picture



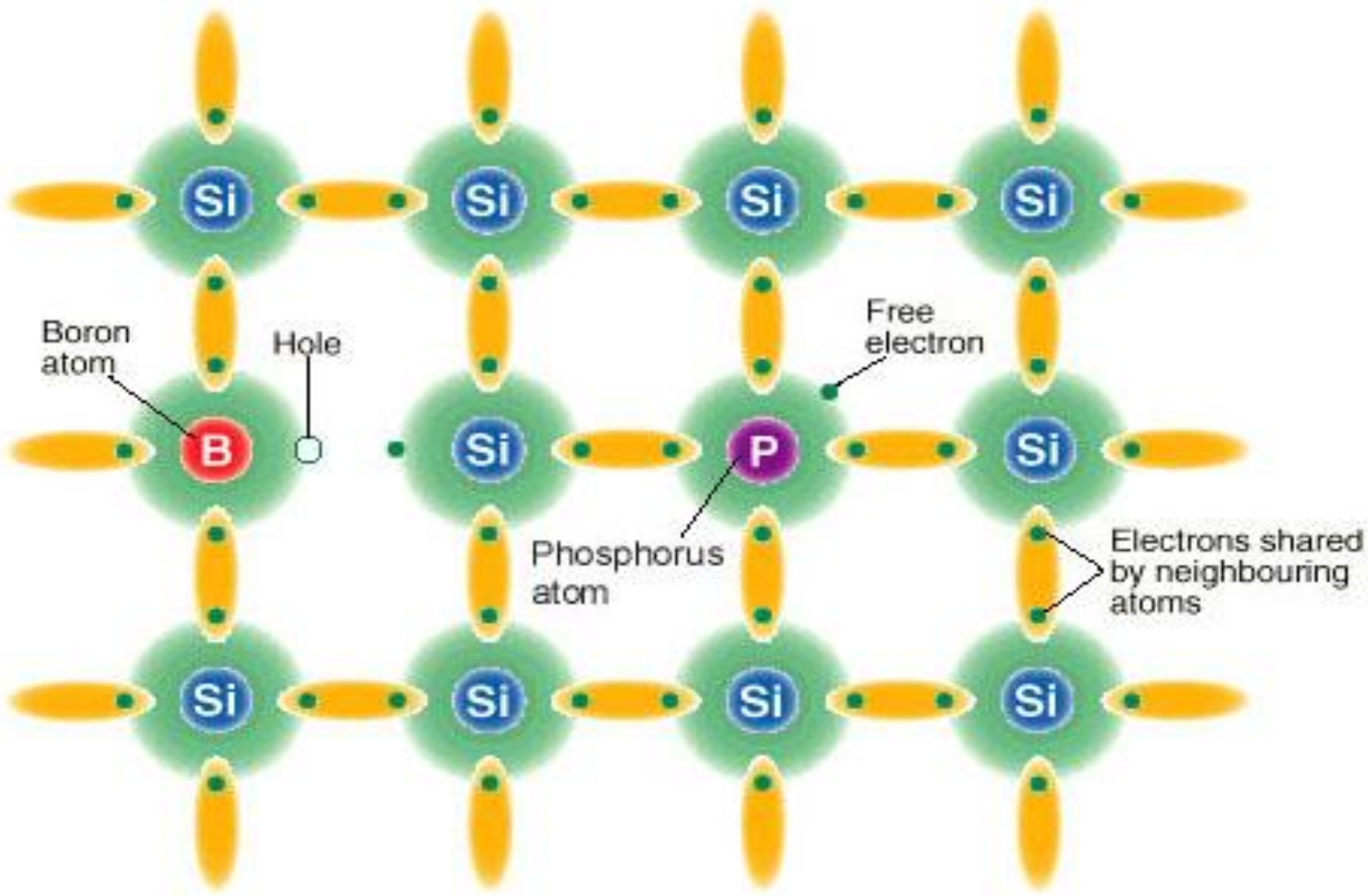
Extrinsic Semiconductors

Adding small amounts of suitable impurity atom can drastically alter number of electrons and holes in a semiconductor !

[illegible]

Addition of a group V element impurity to Silicon should increase electrons while addition of group III element impurity should increase number of holes

Doping



N and P-type Semiconductors

N-type : $n > p$

A Semiconductor such as Silicon doped with a **donor impurity** such as **Phosphorous or Arsenic** from group V of periodic table. The donor impurity donates an electron to conduction band thereby increasing their concentration

P-type : $p > n$

A Semiconductor such as Silicon doped with a **Acceptor impurity** such as **Boron** from group III of periodic table. The acceptor impurity increases number of holes in valence band.

No. of silicon atoms per unit volume

$$\sim 4 \times 10^{22} \text{ cm}^{-3}$$

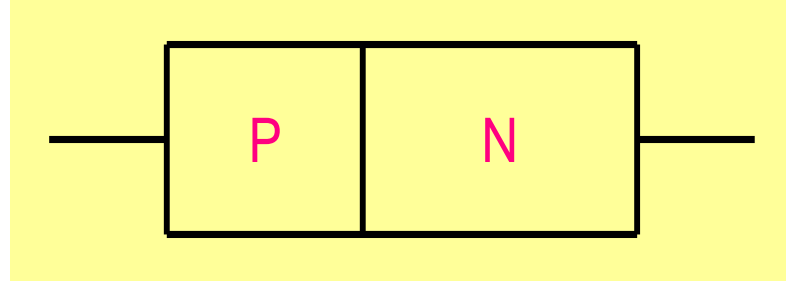
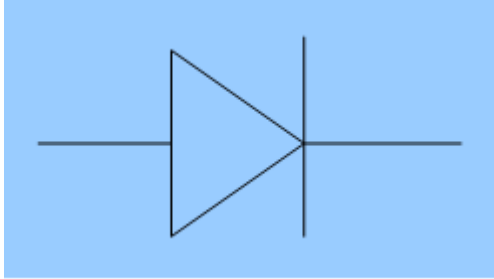
Impurity concentration :

$$N_A = 10^{17} \text{ cm}^{-3}$$

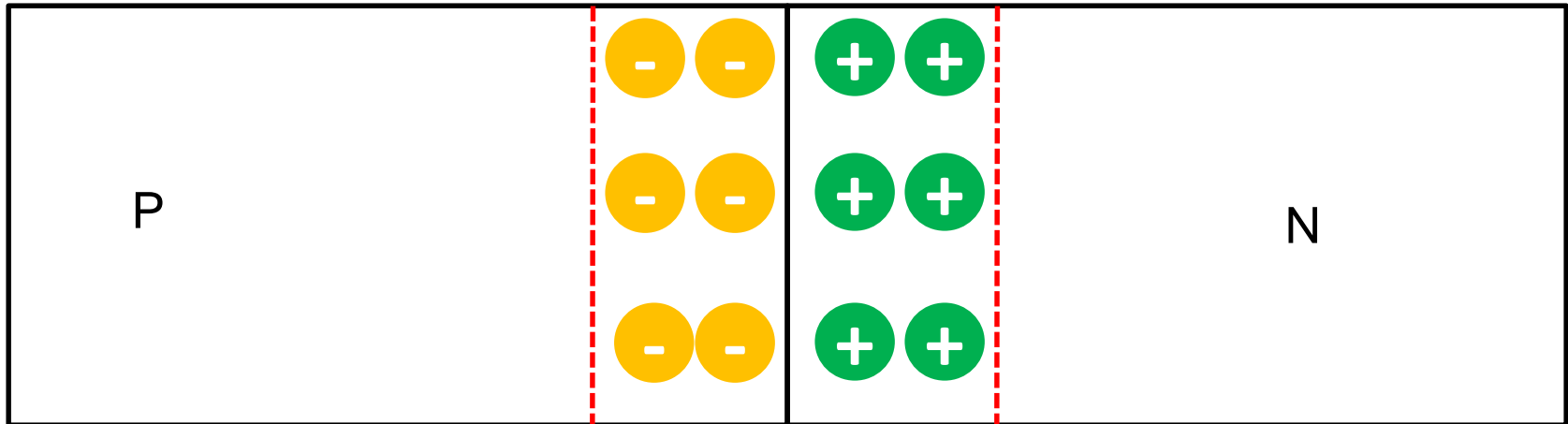
1 in 400,000 Silicon atoms is replaced by Boron

Very small amounts of impurity atoms can cause a drastic change in electrical property of a semiconductor.

PN Junction Diode

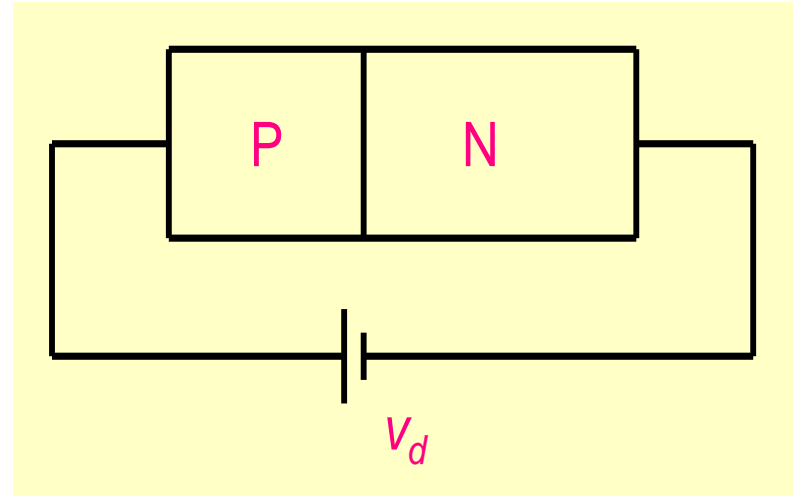
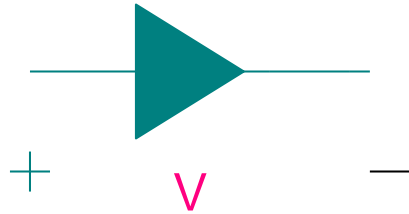


Inside a PN junction at equilibrium (zero applied voltage), there is built-in voltage with N region being positive and P-region negative.

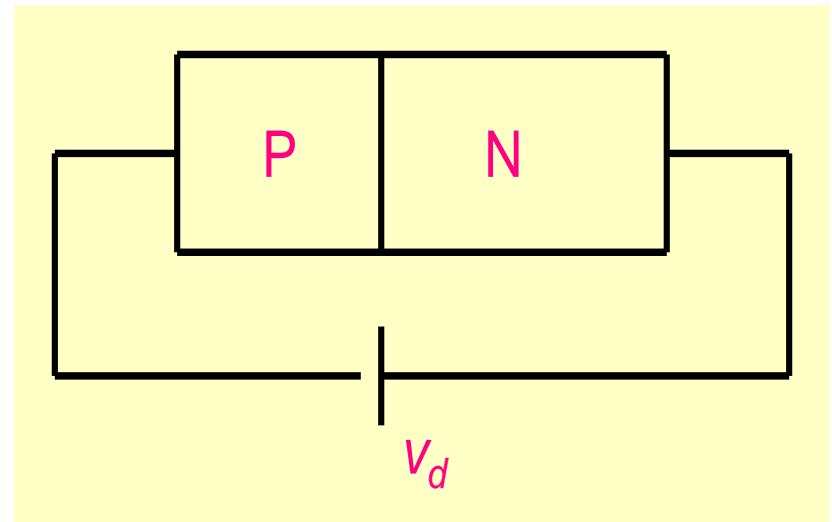
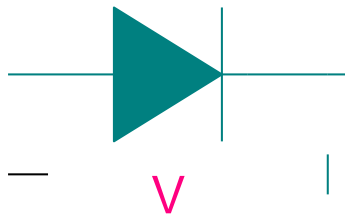


The built-in voltage (also called potential barrier) prevents electrons and holes to give rise to current.

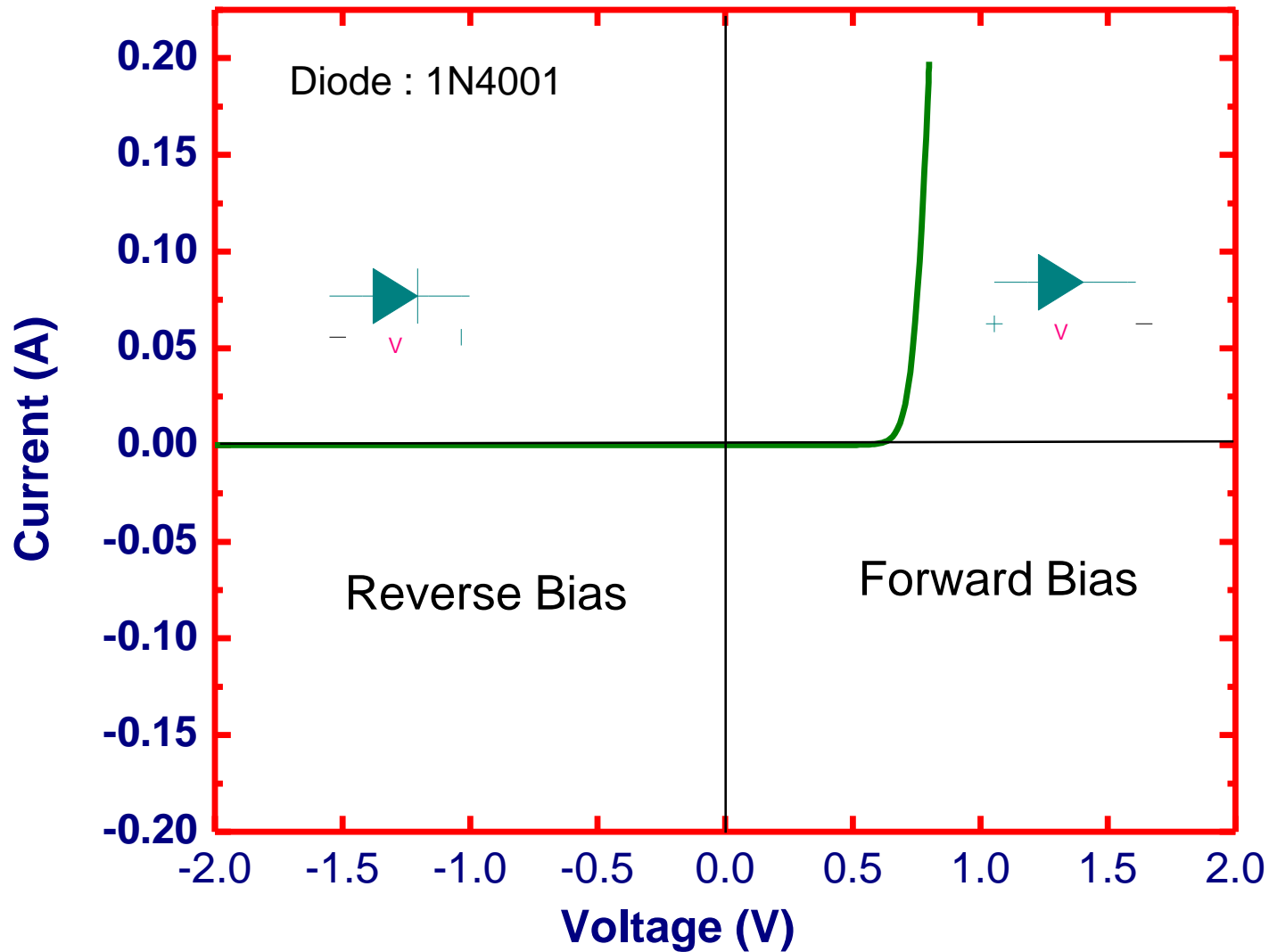
Forward and Reverse Bias



Forward Bias: P is biased at a higher voltage compared to N. It lowers the built-in potential and allows current to flow.

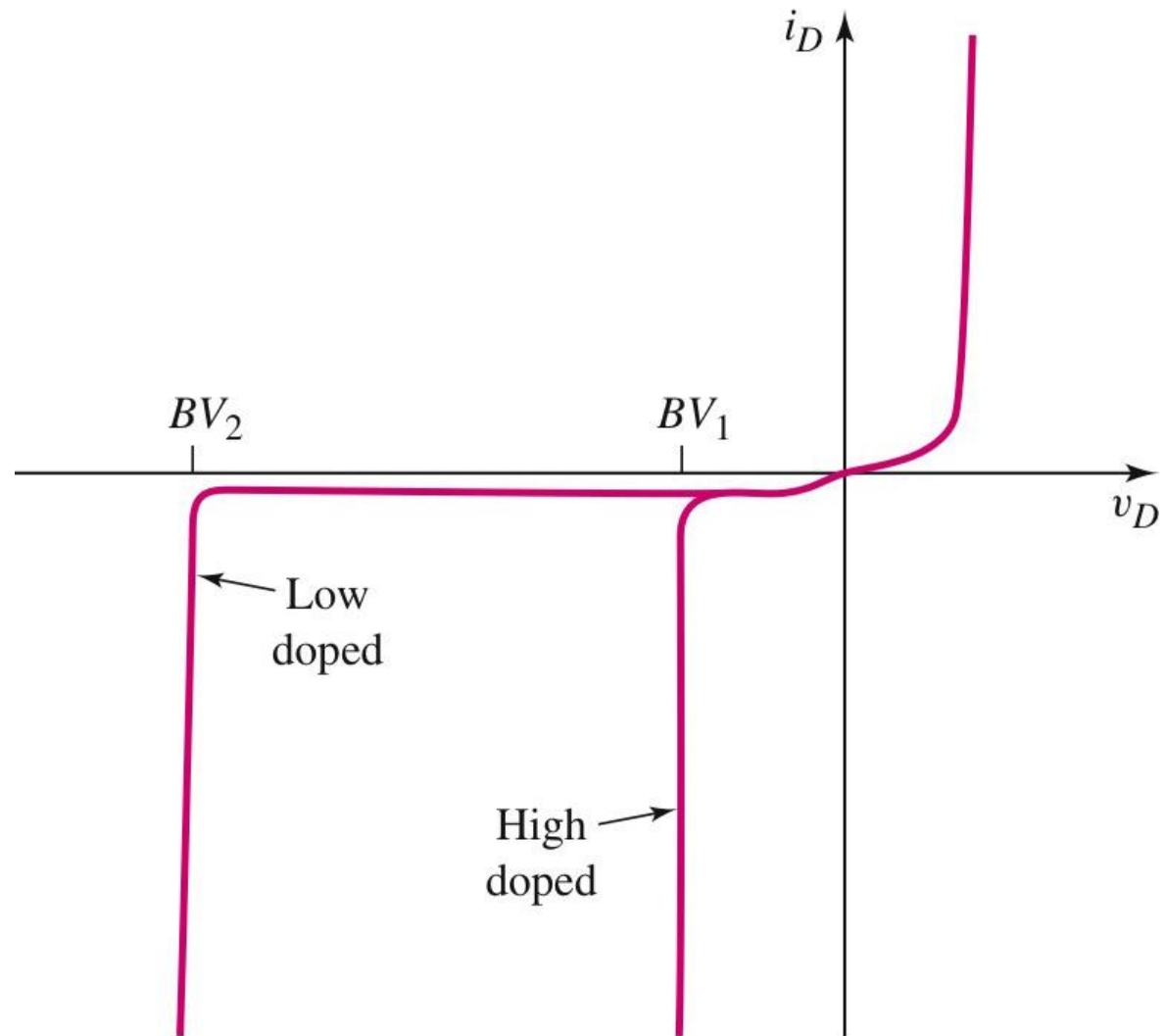


Reverse Bias: N is biased at a higher voltage compared to P. This increases built-in potential and very little current flows.



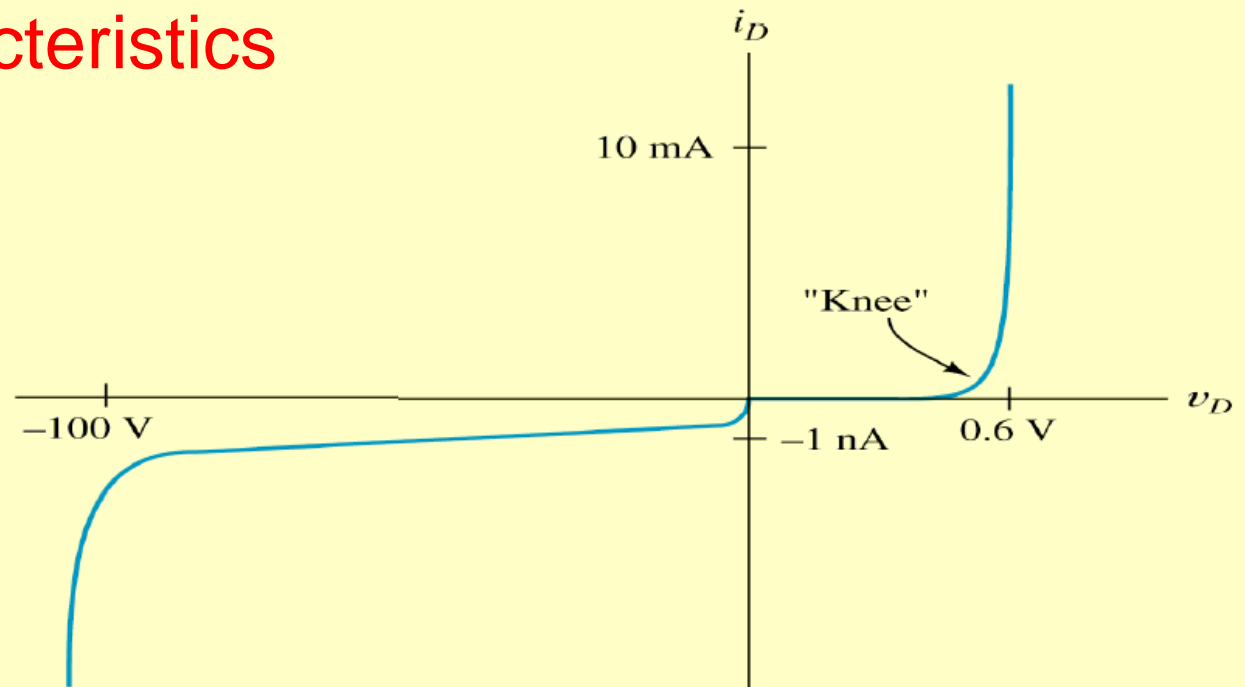
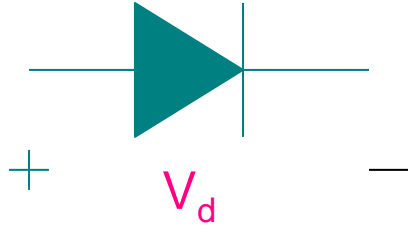
The p-n junction only conducts significant current in the forward-bias region.

Breakdown



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Diode : I-V Characteristics



$$i_D = I_S \times \left\{ \exp\left(\frac{v_d}{nV_T}\right) - 1 \right\}$$

I_S : Reverse Saturation Current

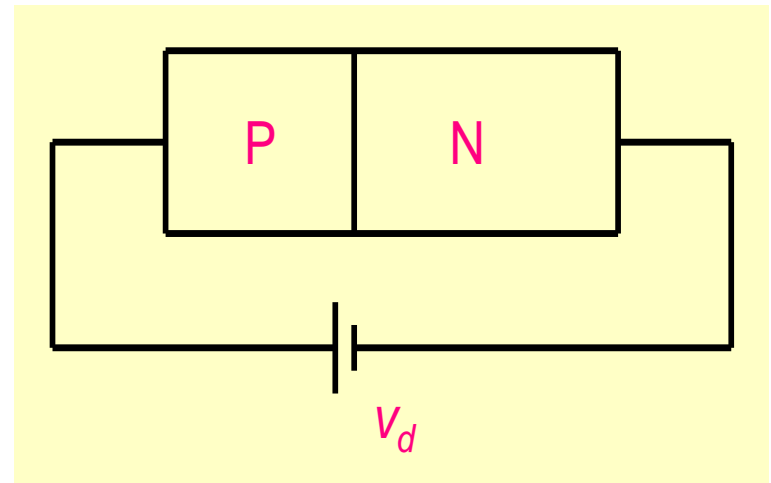
i_d : diode current; v_d : applied voltage

$$V_T = kT / q \cong 26mV \text{ at } T = 300K$$

n is called ideality factor and is equal to 1 for ideal diodes

Forward Bias

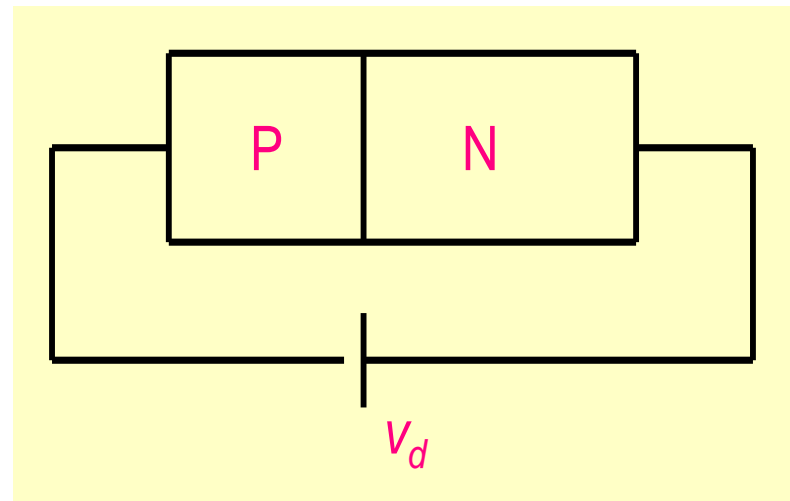
$$v_d \gg V_T = 26mV$$



$$i_D = I_S \times \left\{ \exp\left(\frac{v_d}{V_T}\right) - 1 \right\}$$

$$i_D \cong I_S \times \exp\left(\frac{v_d}{V_T}\right)$$

Reverse Bias



$$i_D = I_S \times \left\{ \exp\left(\frac{v_d}{V_T}\right) - 1 \right\}$$

$$v_d = -v_R$$

$$i_D = I_S \times \left\{ \exp\left(-\frac{v_R}{V_T}\right) - 1 \right\} \cong -I_S$$

$$|v_R| \gg V_T$$

Example

At a temperature of 300 K, the diode current is $i_D=0.1\text{mA}$ for $v_D = 0.6\text{ V}$. Let $n = 1$ and $V_T = 26\text{mV}$. Find the saturation current I_s . Then compute the diode current when $v_D = 0.65\text{V}$ and at 0.7 V .

$$i_D = I_s \left[\exp \left(\frac{v_D}{nV_T} \right) - 1 \right]$$

$$\begin{aligned} I_s &= \frac{i_D}{\exp(v_D / nV_T) - 1} \\ &= \frac{10^{-4}}{\exp(0.600 / 0.026) - 1} \\ &= 9.502 \times 10^{-15} \text{ A} \end{aligned}$$

$$i_D = I_s \left[\exp \left(\frac{v_D}{nV_T} \right) - 1 \right]$$

Then for $v_D = 0.650$ V, we have:

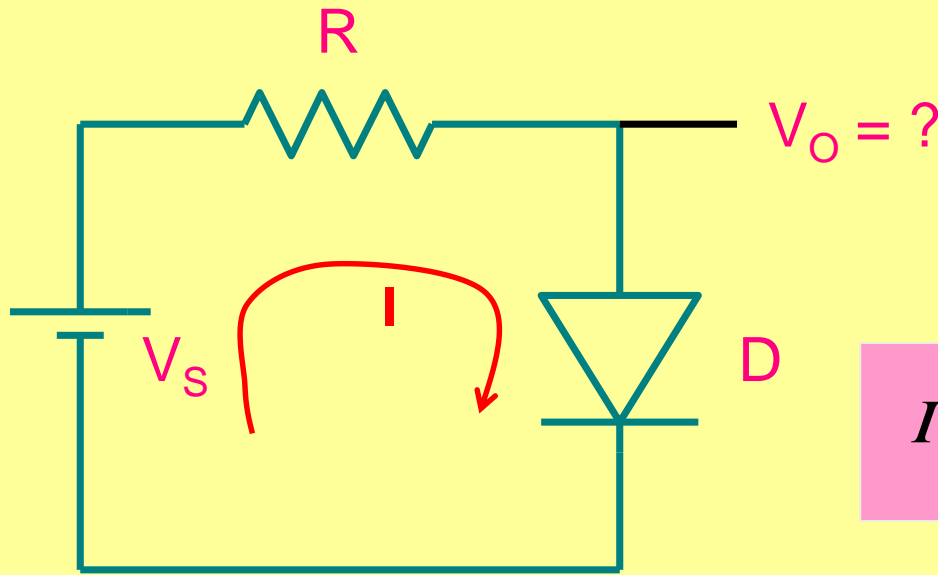
$$\begin{aligned} i_D &= I_s [\exp(v_D / nV_T) - 1] = 9.502 \times 10^{-15} \times [\exp(0.650 / 0.026) - 1] \\ &= 0.6841 \text{ mA} \end{aligned}$$

Similarly for $v_D = 0.700$ V,

$$i_D = 4.681 \text{ mA}$$

Notice the difference
in current
for 0.05 difference in v_D

Analysis using non-linear diode model is not easy



$$V_S = I \times R + V_O \quad (1)$$

$$I = I_S \times \left\{ \exp\left(\frac{V_O}{nV_T}\right) - 1 \right\} \quad (2)$$

$$\Rightarrow V_O = nV_T \times \ln\left(\frac{I}{I_S} + 1\right) \quad (3)$$

$$\Rightarrow V_S = IR + nV_T \times \ln\left(\frac{I}{I_S} + 1\right) \quad (4)$$

Iterative Method:

$$V_s = IR + V_o \quad (1)$$

$$V_o = nV_T \times \ln\left(\frac{I}{I_s} + 1\right) \quad (3)$$

Assume

$$V_o = 0.6V$$

Calculate

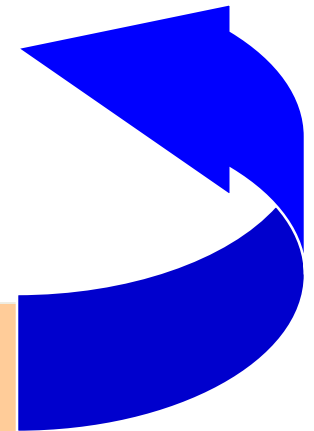
$$I = \frac{V_s - V_o}{R}$$

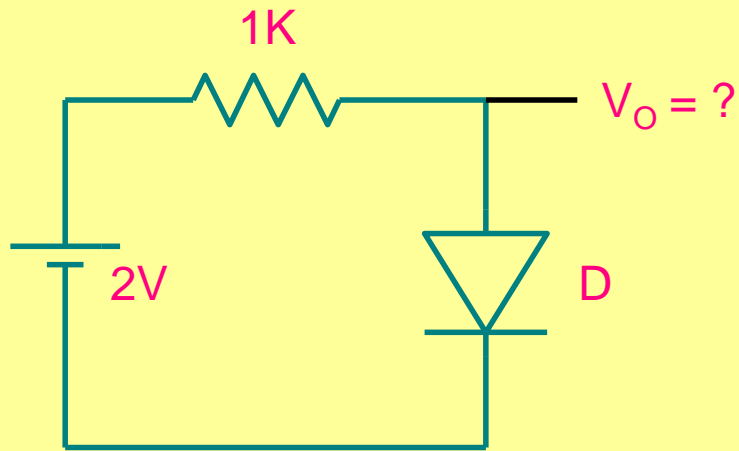
Re-calculate

$$V_o = nV_T \times \ln(I/I_s + 1)$$

Convergence:

$$\frac{\Delta I}{I} \leq \varepsilon$$





$$i_D = I_S \times \left\{ \exp\left(\frac{V}{V_T}\right) - 1 \right\}$$

$$I_S = 2 \times 10^{-15} \text{ A}$$

$$V_T = kT / q \cong 26 \text{ mV}$$

$$\text{at } T = 300 \text{ K}$$

Assume V_O

$$V_O = 0.5$$

$$V_O = 0.711$$

$$V_O = 0.707$$

$$I = \frac{V_S - V_O}{R}$$

$$I = 1.5 \times 10^{-3} \quad I = 1.289 \times 10^{-3} \quad I = 1.293 \times 10^{-3}$$

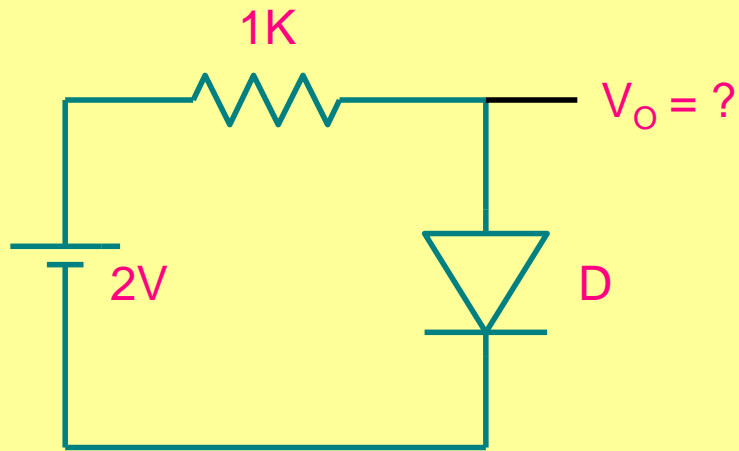
$$V_O = 0.711$$

$$V_O = 0.707$$

$$V_O = 0.707$$

$$V_O = nV_T \times \ln(I/I_S + 1)$$

CONVERGENCE



$$i_D = I_S \times \left\{ \exp\left(\frac{V}{V_T}\right) - 1 \right\}$$

$$I_S = 2 \times 10^{-15} \text{ A}$$

$$V_T = kT / q \cong 26 \text{ mV} \quad \text{at } T = 300 \text{ K}$$

Assume V_O

$$V_O = 1.0$$

$$V_O = 0.7$$

$$V_O = 0.707$$

$$I = \frac{V_S - V_O}{R}$$

$$I = 1.0 \times 10^{-3}$$

$$I = 1.3 \times 10^{-3}$$

$$I = 1.293 \times 10^{-3}$$

$$V_O = 0.7$$

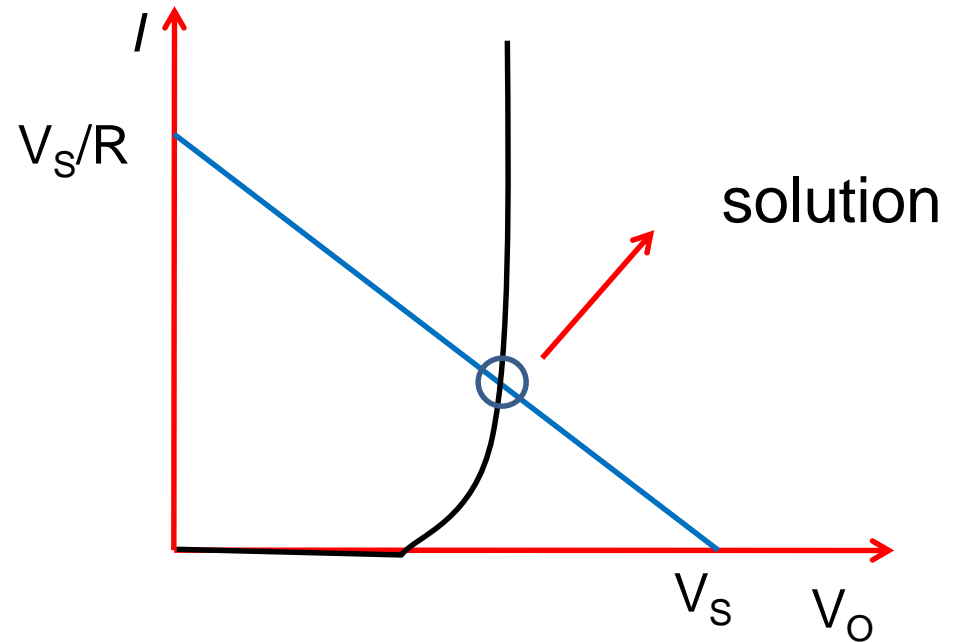
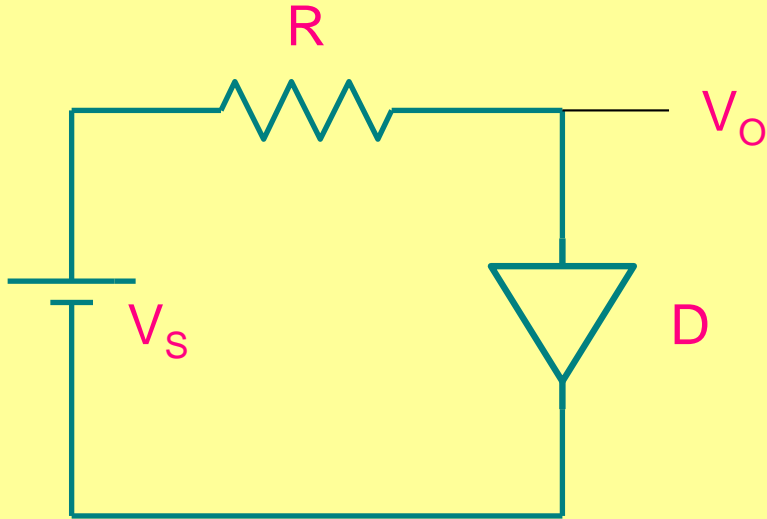
$$V_O = 0.707$$

$$V_O = 0.707$$

$$V_O = nV_T \times \ln(I/I_S + 1)$$

CONVERGENCE to the same Result

Graphical Method: Method of Load Line



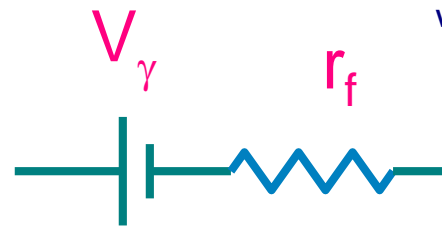
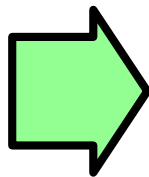
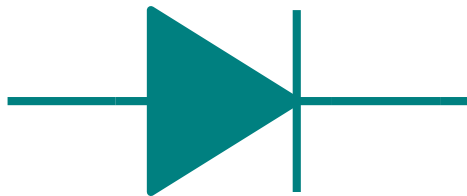
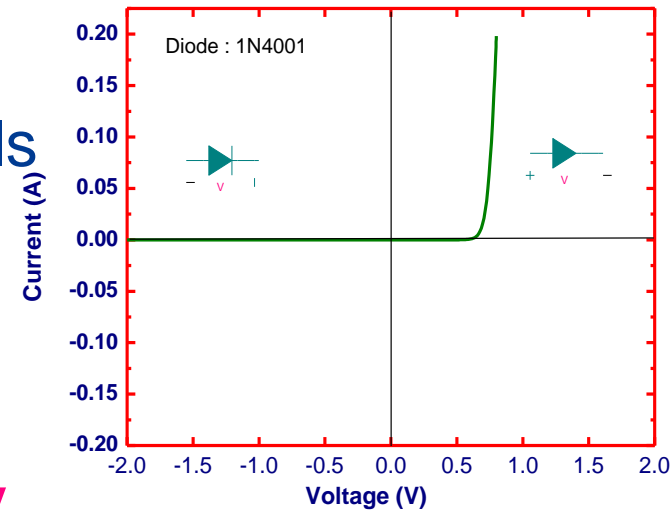
$$V_S = I \times R + V_O$$
$$\Rightarrow I = \frac{V_S - V_O}{R}$$

$$I = I_S \times \left\{ \exp\left(\frac{V_O}{nV_T}\right) - 1 \right\}$$

How about something that is
simple & easy to work with

- Analysis using a **non-linear** diode model is relatively difficult and time consuming.
- It also does not give a symbolic expression that can provide insight and help in the design of the circuit.

Need **SIMPLER** and **LINEAR** Device Models



$$V > V_\gamma$$

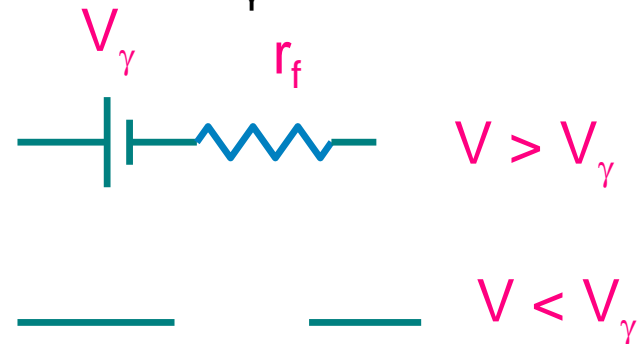
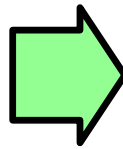
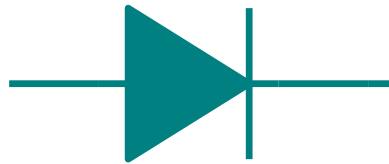
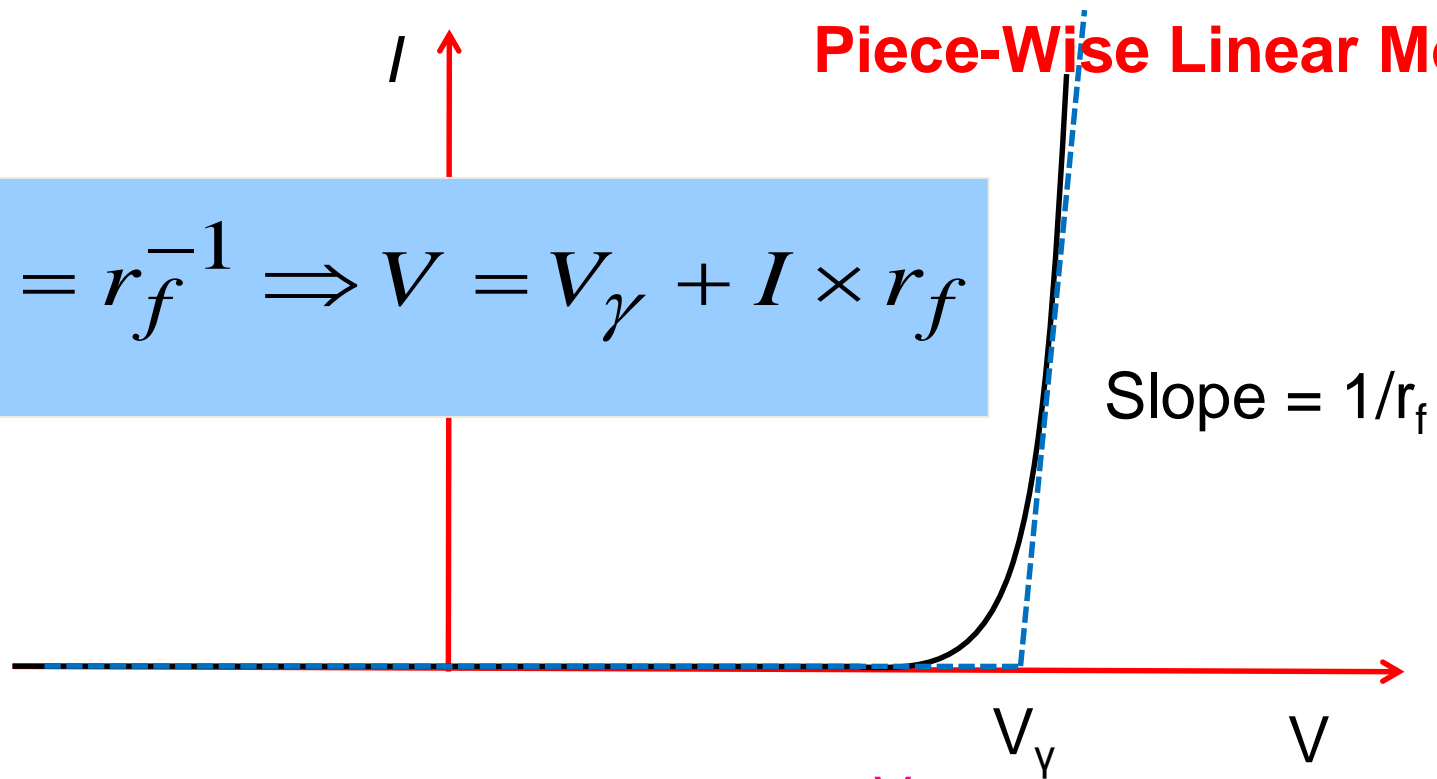


$$V < V_\gamma$$

open circuit

Piece-Wise Linear Model

$$\frac{I - 0}{V - V_\gamma} = r_f^{-1} \Rightarrow V = V_\gamma + I \times r_f$$

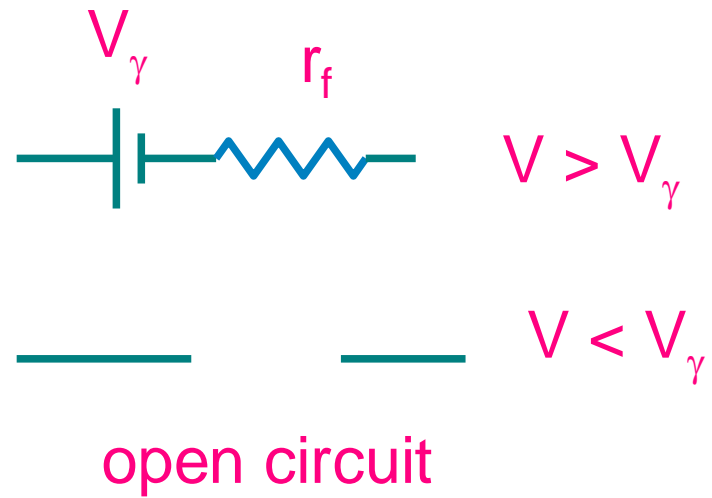
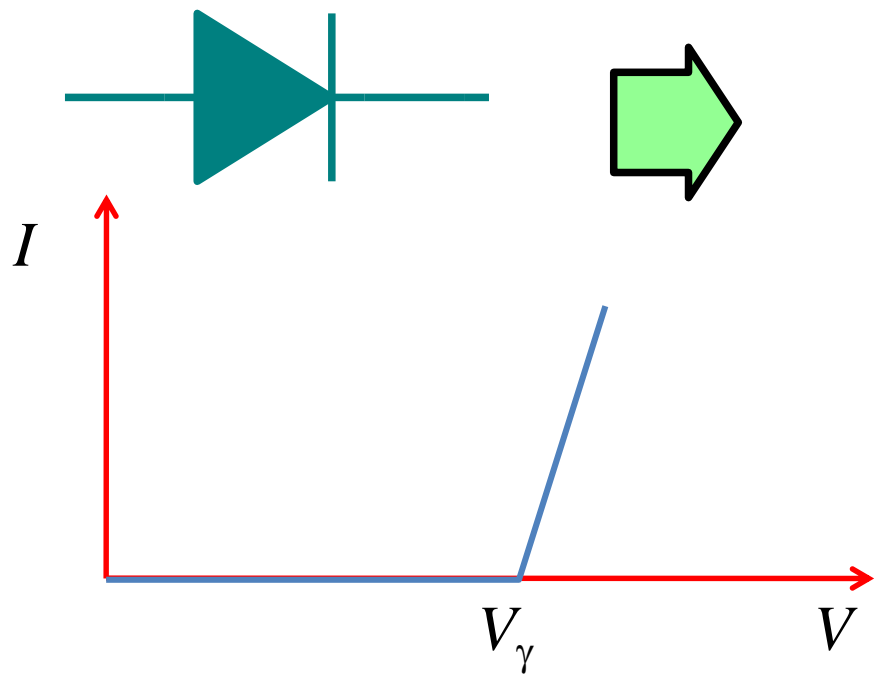


open circuit

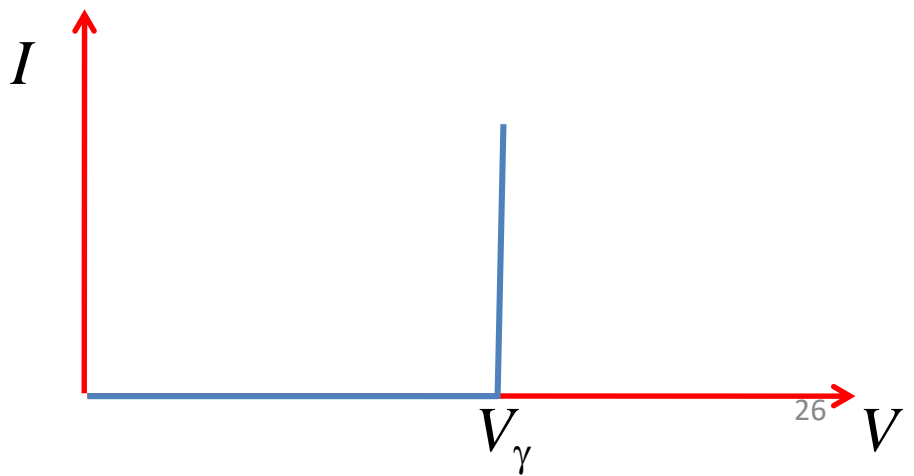
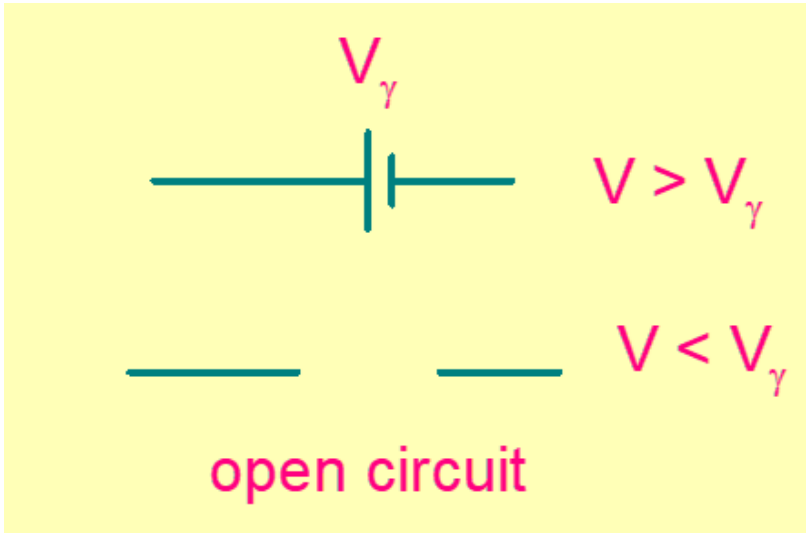
V_γ is called cut-in or turn-on voltage and depends on nature of diode and range of current considered

For most of our analysis, we will take $V_\gamma = 0.7V$ and $r_f \sim 10\Omega$

Even Simpler Diode Models



Constant voltage drop model



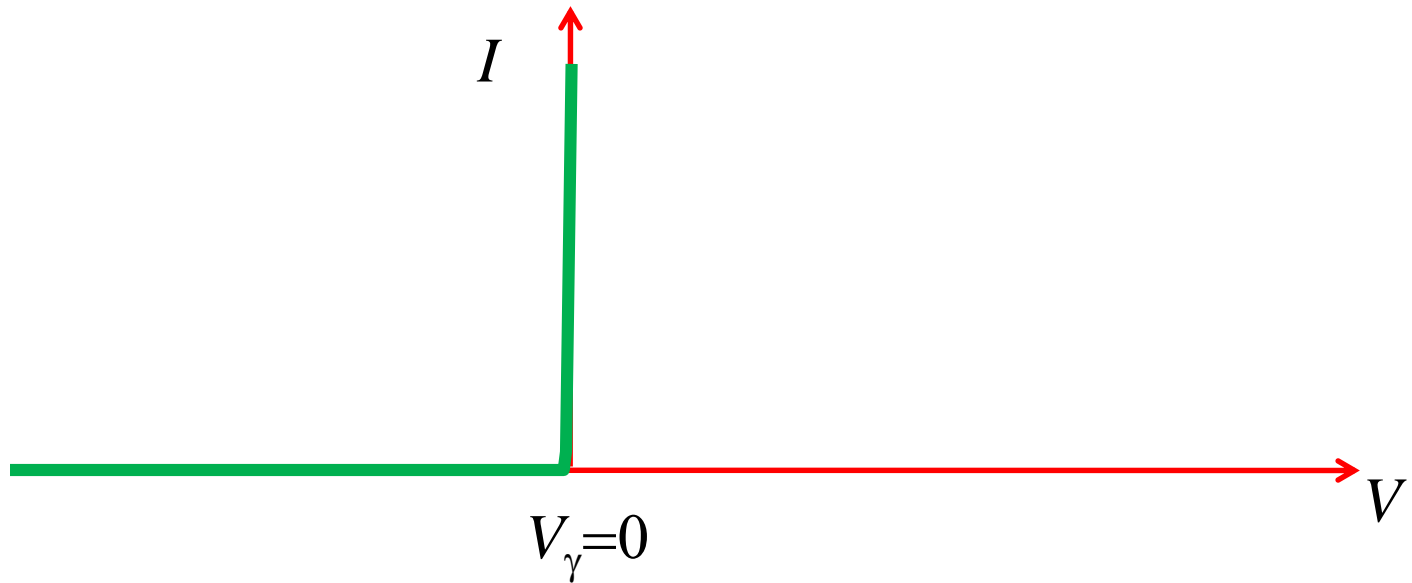
Even Simpler Diode Models

Ideal diode model

$V > 0$

$V < 0$

open circuit



Diode Models

$$i_D = I_S \times \left\{ \exp\left(\frac{v_d}{V_T}\right) - 1 \right\}$$

Simplicity

Accuracy

